

TEST REPORT

Reference No..... : WTX22X03057847W003
FCC ID : YHLBLUN2
Applicant : BLU Products, Inc.
Address : 10814 NW 33rd St # 100 Doral, FL 33172,USA
Manufacturer : The same as Applicant
Address : The same as Applicant
Product Name : Smart Phone
Model No..... : N2
Standards : FCC Part 90
Date of Receipt sample : 2022-03-30
Date of Test..... : 2022-03-30 to 2022-05-28
Date of Issue : 2022-05-28
Test Report Form No. : WTX_Part 90W
Test Result..... : **Pass**

Remarks:

The results shown in this test report refer only to the sample(s) tested, this test report cannot be reproduced, except in full, without prior written permission of the company. The report would be invalid without specific stamp of test institute and the signatures of approver.


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Report version

Version No.	Date of issue	Description
Rev.00	2022-05-28	Original
/	/	/

1. GENERAL INFORMATION

1.1 Product Description for Equipment Under Test (EUT)

General Description of EUT:	
Product Name:	Smart Phone
Trade Name:	BLU
Model No.:	N2
Adding Model(s):	/
Rated Voltage:	DC3.87V
Battery:	4100mAh (C806352410P)
Adapter Model:	US-BM-3000 INPUT:AC100-240V, 50/60Hz, 0.8A Output:DC5V3.0A/DC9V3A/DC10V3A
Software Version:	BOLD_N0050UU_V11.0.04.01_GENERIC
Hardware Version:	Kx3U _01
<i>Note: The test data is gathered from a production sample provided by the manufacturer.</i>	

Technical Characteristics of EUT:	
4G	
Support Networks:	FDD-LTE
Support Band:	FDD-LTE Band 26
Uplink Frequency:	FDD-LTE Band 26: Tx: 814-824MHz,
Downlink Frequency:	FDD-LTE Band 26: Rx: 859-869MHz,
RF Output Power:	FDD-LTE Band 26: 25.43dBm,
Type of Emission:	FDD-LTE Band 26: 8M98G7D, 8M97W7D
Type of Modulation:	QPSK, 16QAM
Antenna Type:	PCB Antenna
Antenna Gain:	FDD-LTE Band 26:-3.7dBi,
<i>Note: The Antenna Gain is provided by the customer and can affect the validity of results.</i>	

1.2 Test Standards

The tests were performed according to following standards:

FCC Rules Part 2: Frequency Allocations and Radio Treaty Matters; General Rules and Regulations.

FCC Rules Part 90: Private Land Mobile Radio Services.

TIA/EIA 603 E March 2016: Land Mobile FM or PM Communications Equipment Measurement and Performance Standards.

ANSI C63.26-2015: American National Standard for Compliance Testing of Transmitters Used in Licensed Radio Services.

KDB 971168 D01 Power Measurement License Digital Systems v03r01: Measurement Guidance for Certification of Licensed Digital Transmitters.

Maintenance of compliance is the responsibility of the manufacturer. Any modification of the product, which result in lowering the emission, should be checked to ensure compliance has been maintained.

1.3 Test Methodology

All measurements contained in this report were conducted with TIA/EIA 603 E/ KDB 971168/ ANSI C63.26

The equipment under test (EUT) was configured to measure its highest possible emission level. The test modes were adapted accordingly in reference to the Operating Instructions.

1.4 Test Facility

FCC – Registration No.: 125990

Waltek Testing Group (Shenzhen) Co., Ltd. Laboratory has been recognized to perform compliance testing on equipment subject to the Commission's Declaration Of Conformity (DOC). The Designation Number is CN5010, and Test Firm Registration Number is 125990.

Industry Canada (IC) Registration No.: 11464A

The 3m Semi-anechoic chamber of Waltek Testing Group (Shenzhen) Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 11464A.

1.5 EUT Setup and Test Mode

The EUT was operated in the engineering mode to fix the Tx frequency that was for the purpose of the measurements. All testing shall be performed under maximum output power condition, and to measure its highest possible emissions level, more detailed description as follows:

Test Mode List		
Test Mode	Description	Remark
TM1	FDD-LTE Band 26	Low, Middle, High Channels

Test Conditions	
Temperature:	22~25 °C
Relative Humidity:	50~55 %.
ATM Pressure:	1019 mbar

EUT Cable List and Details			
Cable Description	Length (m)	Shielded/Unshielded	With / Without Ferrite
USB Cable	1.0	Shielded	Without Ferrite
Headset Cable	1.2	Unshielded	Without Ferrite

Special Cable List and Details			
Cable Description	Length (m)	Shielded/Unshielded	With / Without Ferrite
/	/	/	/

Auxiliary Equipment List and Details			
Description	Manufacturer	Model	Serial Number
Notebook	ASUS	FA5061C	M8NRCX057996349

1.6 Measurement Uncertainty

Measurement uncertainty		
Parameter	Conditions	Uncertainty
RF Output Power	Conducted	$\pm 0.42\text{dB}$
Occupied Bandwidth	Conducted	$\pm 1.5\%$
Frequency Stability	Conducted	2.3%
Transmitter Spurious Emissions	Conducted	$\pm 0.42\text{dB}$
Transmitter Spurious Emissions	Radiated	30-200MHz $\pm 4.52\text{dB}$
		0.2-1GHz $\pm 5.56\text{dB}$
		1-6GHz $\pm 3.84\text{dB}$
		6-18GHz $\pm 3.92\text{dB}$

1.7 Test Equipment List and Details

No.	Description	Manufacturer	Model	Serial No.	Cal Date	Due. Date
SEMT-1075	Communication Tester	Rohde & Schwarz	CMW500	148650	2022-03-22	2023-03-21
SEMT-1072	Spectrum Analyzer	Agilent	E4407B	MY41440400	2022-03-22	2023-03-21
SEMT-1079	Spectrum Analyzer	Agilent	N9020A	US47140102	2022-03-25	2023-03-24
SEMT-1080	Signal Generator	Agilent	83752A	3610A01453	2022-03-22	2023-03-21
SEMT-1081	Vector Signal Generator	Agilent	N5182A	MY47070202	2022-03-22	2023-03-21
SEMT-1028	Power Divider	Weinschel	1506A	PM204	2022-03-22	2023-03-21
SEMT-C001	Cable	Zheng DI	LL142-07-07-10M(A)	/	/	/
SEMT-C002	Cable	Zheng DI	ZT40-2.92J-2.92J-6M	/	/	/
SEMT-C003	Cable	Zheng DI	ZT40-2.92J-2.92J-2.5M	/	/	/
SEMT-C004	Cable	Zheng DI	2M0RFC	/	/	/
SEMT-C005	Cable	Zheng DI	1M0RFC	/	/	/
SEMT-C006	Cable	Zheng DI	1M0RFC	/	/	/
<input checked="" type="checkbox"/> Chamber A: Below 1GHz						
SEMT-1031	Spectrum Analyzer	Rohde & Schwarz	FSP30	836079/035	2022-03-22	2023-03-21
SEMT-1007	EMI Test Receiver	Rohde & Schwarz	ESVB	825471/005	2022-03-22	2023-03-21
SEMT-1008	Amplifier	Agilent	8447F	3113A06717	2022-01-07	2023-01-06
SEMT-1069	Loop Antenna	Schwarz beck	FMZB 1516	9773	2021-03-20	2023-03-19
SEMT-1068	Broadband Antenna	Schwarz beck	VULB9163	9163-333	2021-03-20	2023-03-19
<input checked="" type="checkbox"/> Chamber A: Above 1GHz						
SEMT-1031	Spectrum Analyzer	Rohde & Schwarz	FSP30	836079/035	2022-03-22	2023-03-21
SEMT-1007	EMI Test Receiver	Rohde & Schwarz	ESVB	825471/005	2022-03-22	2023-03-21
SEMT-1043	Amplifier	C&D	PAP-1G18	2002	2022-03-22	2023-03-21
SEMT-1042	Horn Antenna	ETS	3117	00086197	2021-03-19	2023-03-18
SEMT-1121	Horn Antenna	Schwarzbeck	BBHA 9170	BBHA9170582	2021-04-27	2023-04-26
SEMT-1216	Pre-amplifier	Schwarzbeck	BBV 9721	9721-031	2022-03-25	2023-03-24
SEMT-1163	Spectrum Analyzer	Rohde & Schwarz	FSP40	100612	2022-03-22	2023-03-21
<input type="checkbox"/> Chamber B:Below 1GHz						
SEMT-1068	Trilog	Schwarz beck	VULB9163(B)	9163-635	2021-04-09	2023-04-08

	Broadband Antenna					
SEMT-1067	Amplifier	Agilent	8447D	2944A10179	2022-03-22	2023-03-21
SEMT-1066	EMI Test Receiver	Rohde & Schwarz	ESPI	101391	2022-03-22	2023-03-21
<input type="checkbox"/> Chamber C: Below 1GHz						
SEMT-1319	EMI Test Receiver	Rohde & Schwarz	ESIB 26	100401	2022-01-07	2023-01-06
SEMT-1343	Trilog Broadband Antenna	Schwarz beck	VULB 9168	1194	2021-05-28	2023-05-27
SEMT-1333	Amplifier	HP	8447F	2944A03869	2022-03-22	2023-03-21

Software List			
Description	Manufacturer	Model	Version
EMI Test Software (Radiated Emission)*	Farad	EZ-EMC	RA-03A1
LTE Test System*	Tonscend	JS1120-1	V2.5

*Remark: indicates software version used in the compliance certification testing.

2. SUMMARY OF TEST RESULTS

FCC Rules	Description of Test Item	Result
§1.1307, §2.1093	RF Exposure	Compliant
§ 90.635	RF Output Power	Compliant
-	Peak-to-average Ratio (PAR) of Transmitter	Compliant
§ 90.691	Emission Bandwidth	Compliant
§ 90.691	Spurious Emissions at Antenna Terminal	Compliant
§ 90.691	Spurious Radiation Emissions	Compliant
§2.917(a), § 90.691	Out of Band Emissions	Compliant
§ 90.213	Frequency Stability	Compliant

N/A: Not applicable.

3. RF Exposure

3.1 Standard Applicable

According to §1.1307 and §2.1093, the portable transmitter must comply the RF exposure requirements.

3.2 Test Result

This product complied with the requirement of the RF exposure, please see the SAR report.

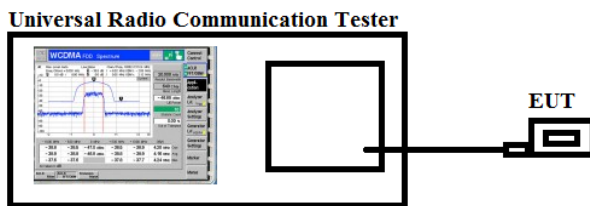
4. RF Output Power

4.1 Standard Applicable

According to §90.635, Limitations on power and antenna height.

4.2 Test Procedure

- Conducted output power test method:



- Radiated power test method:

1. The setup of EUT is according with per ANSI/TIA Standard 603E and ANSI C63.26 measurement procedure.
2. The measurement antenna was placed at a distance of 3 meters from the EUT. During the tests, the antenna height and polarization as well as EUT azimuth were varied in order to identify the maximum level of emissions from the EUT. The test was performed by placing the EUT on 3-orthogonal axis.
3. The frequency range up to tenth harmonic of the fundamental frequency was investigated.
4. Remove the EUT and replace it with substitution antenna. A signal generator was connected to the substitution antenna by a non-radiating cable. The absolute levels of the spurious emissions were measured by the substitution.

4.3 Summary of Test Results/Plots

Max. Radiated Power:

Channel Bandwidth: 1.4MHz			
Modulation	Channel	E.r.p [dBm]	Verdict
QPSK	LCH	20.13	PASS
	MCH	20.08	PASS
	HCH	20.42	PASS
16QAM	LCH	20.32	PASS
	MCH	20.12	PASS
	HCH	20.28	PASS
Channel Bandwidth: 3MHz			
Modulation	Channel	E.r.p [dBm]	Verdict
QPSK	LCH	20.16	PASS
	MCH	20.28	PASS
	HCH	20.11	PASS
16QAM	LCH	20.28	PASS
	MCH	20.39	PASS
	HCH	20.17	PASS
Channel Bandwidth: 5MHz			
Modulation	Channel	E.r.p [dBm]	Verdict
QPSK	LCH	20.28	PASS
	MCH	20.12	PASS
	HCH	20.85	PASS
16QAM	LCH	20.36	PASS
	MCH	20.14	PASS
	HCH	20.27	PASS
Channel Bandwidth: 10MHz			
Modulation	Channel	E.r.p [dBm]	Verdict
QPSK	MCH	20.39	PASS
16QAM	MCH	20.46	PASS

Max. Conducted Output Power

Please refer to Appendix A: Average Power Output Data

Test result: Pass

5. Peak-to-average Ratio (PAR) of Transmitter

5.1 Standard Applicable

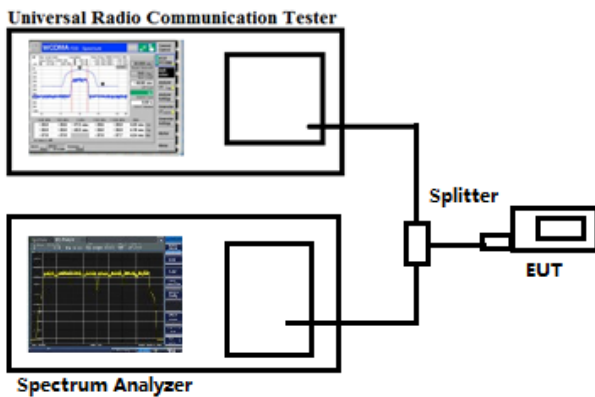
N/A

5.2 Test Procedure

According with KDB 971168

1. The signal analyzer's CCDF measurement profile is enabled.
2. Frequency = carrier center frequency.
3. Measurement BW > Emission bandwidth of signal.
4. The signal analyzer was set to collect one million samples to generate the CCDF curve.
5. The measurement interval was set depending on the type of signal analyzed. For continuous signals (>98% duty cycle), the measurement interval was set to 1ms. For burst transmissions, the spectrum analyzer is set to use an internal "RF Burst" trigger that is synced with an incoming pulse and the measurement interval is set to less than the duration of the "on time" of one burst to ensure that energy is only captured during a time in which the transmitter is operating at maximum power.

Test Configuration for the emission bandwidth testing:



5.3 Summary of Test Results

Please refer to Appendix B: Peak-to-Average Ratio

Test result: Pass

6. Emission Bandwidth

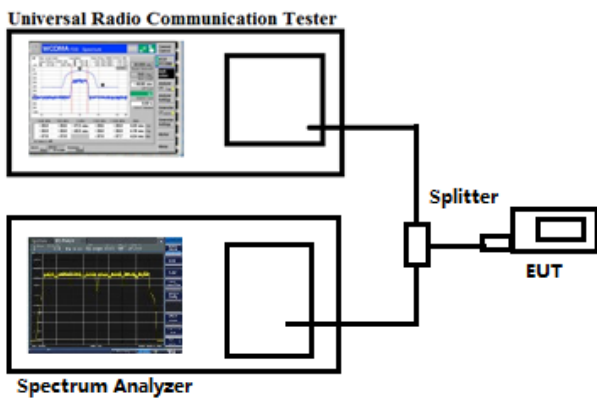
6.1 Standard Applicable

According to §90.691, Emission mask requirements for EA-based systems.

6.2 Test Procedure

According to §22.917(b), the emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emissions are attenuated at least 26dB below the transmitter power.

Test Configuration for the emission bandwidth testing:



6.3 Summary of Test Results/Plots

Please refer to Appendix C: 26dB Bandwidth and Occupied Bandwidth

Test result: Pass

7. Out of Band Emissions at Antenna Terminal

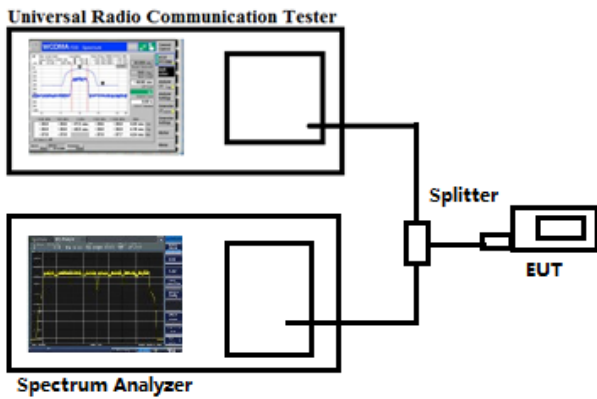
7.1 Standard Applicable

According to §90.691, Emission mask requirements for EA-based systems.

7.2 Test Procedure

The RF output terminal of the transmitter was connected to the input of the spectrum analyzer via a suitable attenuation. The RBW of the spectrum analyzer was set to 100kHz and 1MHz for the scan frequency from 30MHz to 1GHz and the scan frequency from 1GHz to up to 10th harmonic.

Test Configuration for the out of band emissions testing:



7.3 Summary of Test Results/Plots

Please refer to Appendix D & E: Band Edge & Conducted Spurious Emission

Test result: Pass

8. Spurious Radiated Emissions

8.1 Standard Applicable

According to §90.691, Emission mask requirements for EA-based systems.

8.2 Test Procedure

1. The setup of EUT is according with per ANSI/TIA-603-E and ANSI C63.4-2014 measurement procedure.
2. The measurement antenna was placed at a distance of 3 meters from the EUT. During the tests, the antenna height and polarization as well as EUT azimuth were varied in order to identify the maximum level of emissions from the EUT. The test was performed by placing the EUT on 3-orthogonal axis.
3. The frequency range up to tenth harmonic of the fundamental frequency was investigated.
4. Remove the EUT and replace it with substitution antenna. A signal generator was connected to the substitution antenna by a non-radiating cable. The absolute levels of the spurious emissions were measured by the substitution.

$$\text{Spurious attenuation limit in dB} = 43 + 10 \log_{10}(\text{power out in Watts})$$

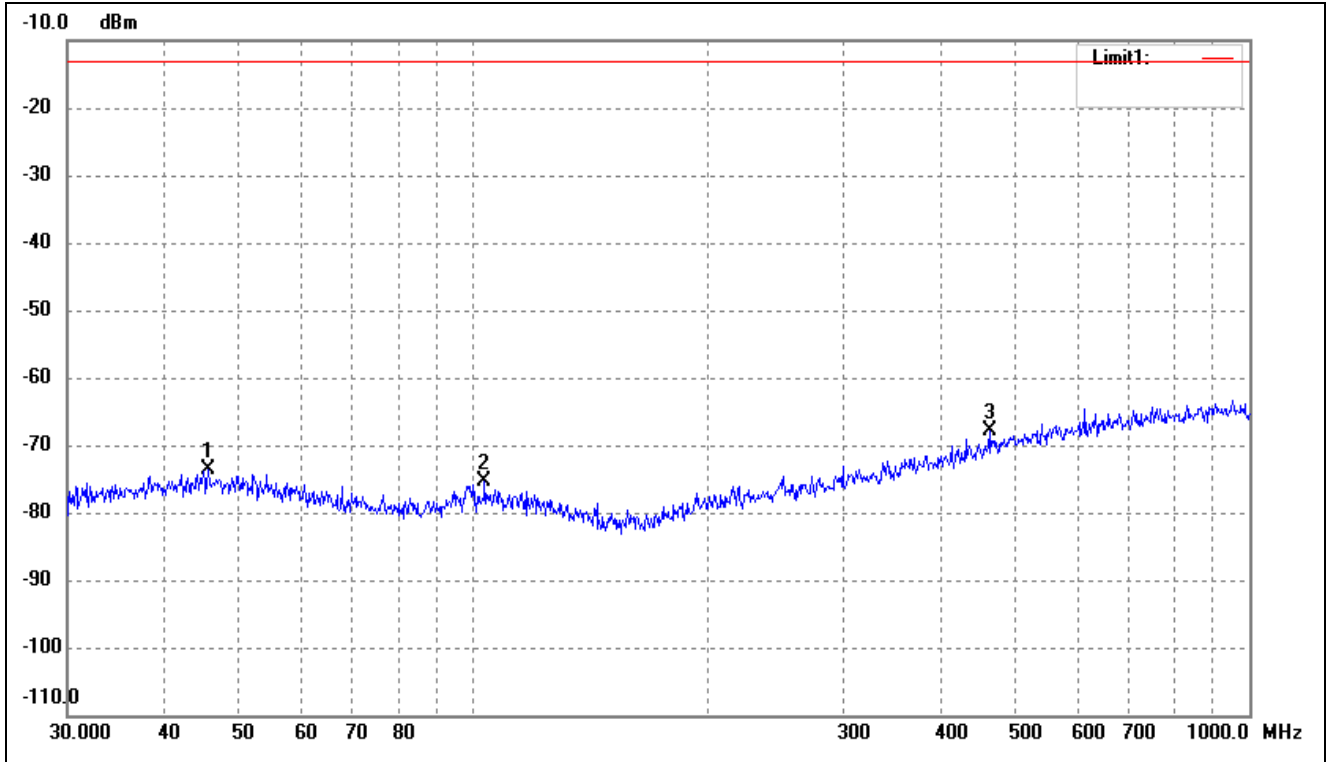
8.3 Summary of Test Results/Plots

Note: 1. this EUT was tested in 3 orthogonal positions and the worst case position data was reported.

2. All test modes (different bandwidth and different modulation) are performed, but only the worst case is recorded in this report.

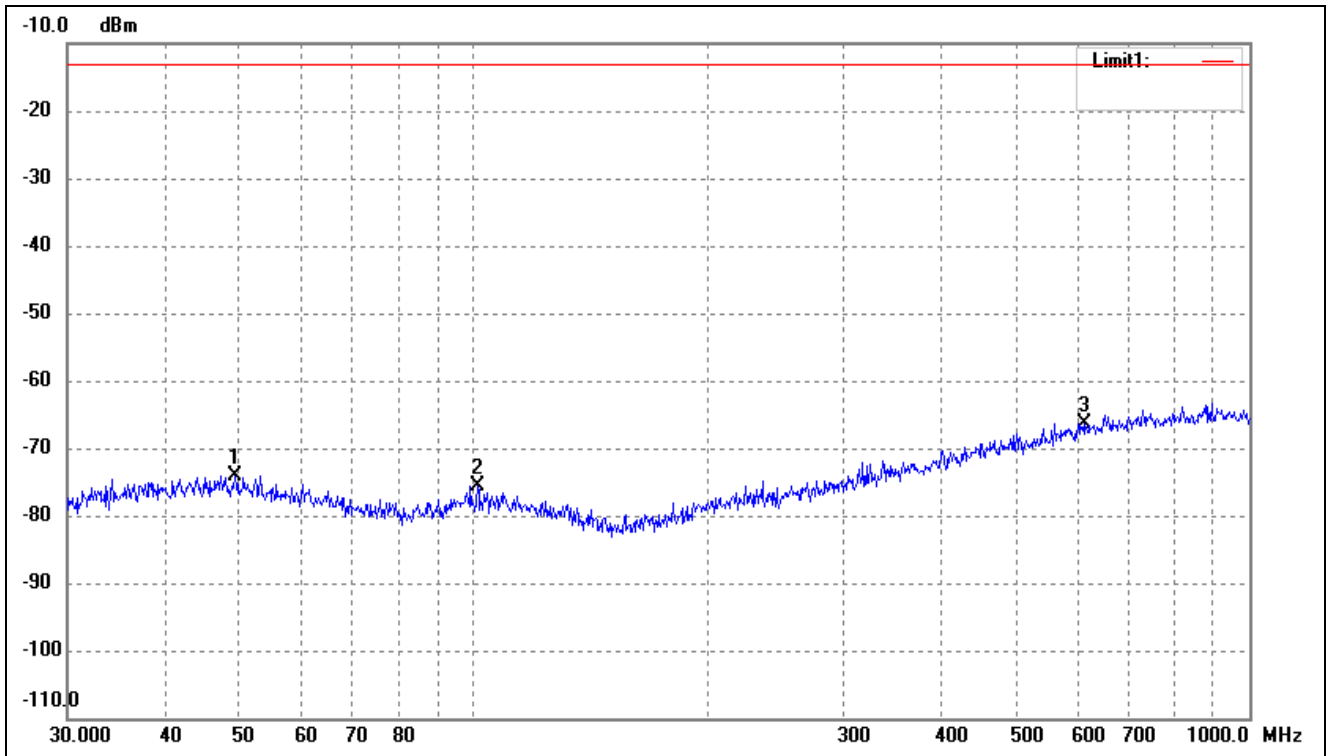
➤ Spurious Emissions Below 1GHz

Test Mode	FDD_LTE Band 26	Polarity:	Horizontal
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No.	Frequency (MHz)	Reading (dBm)	Correct (dB)	Result (dBm)	Limit (dBm)	Margin (dB)	Remark
1	45.5348	-78.55	4.82	-73.73	-13.00	-60.73	ERP
2	103.4421	-78.29	3.02	-75.27	-13.00	-62.27	ERP
3	462.3455	-77.39	9.55	-67.84	-13.00	-54.84	ERP

Test Mode	FDD_LTE Band 26	Polarity:	Vertical
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No.	Frequency (MHz)	Reading (dBm)	Correct (dB)	Result (dBm)	Limit (dBm)	Margin (dB)	Remark
1	49.3594	-78.90	4.84	-74.06	-13.00	-61.06	ERP
2	101.2885	-78.66	3.05	-75.61	-13.00	-62.61	ERP
3	614.2142	-78.60	12.33	-66.27	-13.00	-53.27	ERP

Note: Margin= (Reading+ Correct)- Limit

➤ Spurious Emissions Above 1GHz

For FDD_LTE Band 26 Mode

Frequency	Reading	Correct	Result	Limit	Margin	Polar
(MHz)	(dBm)	dB	(dBm)	(dBm)	(dB)	H/V
Low Channel (814.7MHz)						
1629.40	-34.5	4.83	-29.67	-13	-16.67	H
2444.10	-44.39	8.32	-36.07	-13	-23.07	H
1629.40	-36.28	4.83	-31.45	-13	-18.45	V
2444.10	-43.51	8.32	-35.19	-13	-22.19	V
Middle Channel (819.0MHz)						
1638.00	-37.65	5.01	-32.64	-13	-19.64	H
2457.00	-43.31	8.34	-34.97	-13	-21.97	H
1638.00	-36.5	5.01	-31.49	-13	-18.49	V
2457.00	-42.75	8.34	-34.41	-13	-21.41	V
High Channel (823.3MHz)						
1696.60	-34.64	5.11	-29.53	-13	-16.53	H
2469.90	-42.96	8.27	-34.69	-13	-21.69	H
1696.60	-36.38	5.11	-31.27	-13	-18.27	V
2469.90	-41.64	8.27	-33.37	-13	-20.37	V

*Note: Result=Reading+ Correct, Margin= Result- Limit**Note: Testing is carried out with frequency rang 9kHz to the tenth harmonics, other than listed in the table above are attenuated more than 20dB below the permissible limits or the field strength is too small to be measured.*

9. Frequency Stability

9.1 Standard Applicable

According to §90.213, Frequency stability.

9.2 Test Procedure

According to §2.1055, the following test procedure was performed.

The Frequency Stability is measured directly with a Frequency Domain Analyzer. Frequency Deviation in ppm is calculated from the measured peak to peak value.

The Carrier Frequency Stability over Power Supply Voltage and over Temperature is measured with a Frequency Domain Analyzer in histogram mode.

9.3 Summary of Test Results/Plots

Note: 1.Normal Voltage NV=DC3.85V; Low Voltage LV=DC3.5V; High Voltage HV=DC4.35V

Please refer to Appendix F: Frequency Stability

Test result: Pass

APPENDIX PHOTOGRAPHS

Please refer to “ANNEX”

******* END OF REPORT *******